


<b>Search Notes</b> 	<b>Application/Control No.</b> 10511636	<b>Applicant(s)/Patent Under Reexamination</b> CHEN ET AL.
	<b>Examiner</b> Benjamin Packard	<b>Art Unit</b> 1612

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Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East search updated	1/14/09	BP

INTERFERENCE SEARCH			
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